

# RJF0605JPV

## Silicon N Channel MOS FET Series Power Switching

R07DS1386EJ0100  
Rev.1.00  
Apr 07, 2025

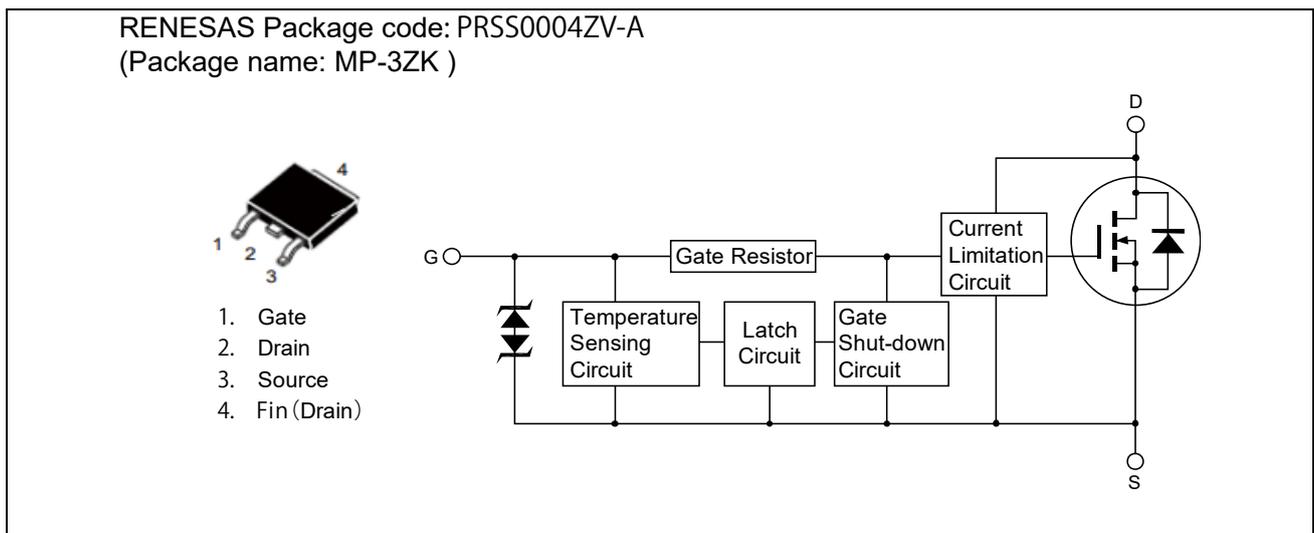
### Description

This FET has the over temperature shut-down capability sensing to the junction temperature. This FET has the built-in over temperature shut-down circuit in the gate area. And this circuit operation to shut-down the gate voltage in case of high junction temperature like applying over power consumption, over current etc..

### Features

- Logic level operation (4 V Gate drive).
- Built-in the over temperature shut-down circuit.
- High endurance capability against to the short circuit.
- Latch type shut down operation (need 0 voltage recovery).
- Built-in the current limitation circuit.
- Power supply voltage applies 12 V and 24 V.
- AEC-Q101 Compliant

### Outline



### Absolute Maximum Ratings

(Ta = 25°C)

| Item                                   | Symbol                            | Ratings     | Unit |
|----------------------------------------|-----------------------------------|-------------|------|
| Drain to source voltage                | V <sub>DSS</sub>                  | 60          | V    |
| Gate to source voltage                 | V <sub>GSS</sub>                  | 16          | V    |
| Gate to source voltage                 | V <sub>GSS</sub>                  | -2.5        | V    |
| Drain current                          | I <sub>D</sub> <sup>Note3</sup>   | 20          | A    |
| Body-drain diode reverse drain current | I <sub>DR</sub>                   | 20          | A    |
| Avalanche current                      | I <sub>AP</sub> <sup>Note 2</sup> | 6.7         | A    |
| Avalanche energy                       | E <sub>AR</sub> <sup>Note 2</sup> | 192         | mJ   |
| Channel dissipation                    | P <sub>ch</sub> <sup>Note 1</sup> | 40          | W    |
| Channel temperature                    | T <sub>ch</sub>                   | 150         | °C   |
| Storage temperature                    | T <sub>stg</sub>                  | -55 to +150 | °C   |

- Notes: 1. Value at Tc = 25°C  
2. T<sub>ch</sub> = 25°C, R<sub>g</sub> ≥ 50 Ω  
3. It provides by the current limitation lower bound value.

## Typical Operation Characteristics

(Ta = 25°C)

| Item                                        | Symbol               | Min | Typ  | Max | Unit | Test Conditions                                                 |
|---------------------------------------------|----------------------|-----|------|-----|------|-----------------------------------------------------------------|
| Input voltage                               | V <sub>IH</sub>      | 3.5 | —    | —   | V    |                                                                 |
|                                             | V <sub>IL</sub>      | —   | —    | 1.2 | V    |                                                                 |
| Input current<br>(Gate non shut down)       | I <sub>IH1</sub>     | —   | —    | 100 | μA   | V <sub>i</sub> = 8 V, V <sub>DS</sub> = 0                       |
|                                             | I <sub>IH2</sub>     | —   | —    | 50  | μA   | V <sub>i</sub> = 3.5 V, V <sub>DS</sub> = 0                     |
|                                             | I <sub>IL</sub>      | —   | —    | 1   | μA   | V <sub>i</sub> = 1.2 V, V <sub>DS</sub> = 0                     |
| Input current<br>(Gate shut down)           | I <sub>IH(sd)1</sub> | —   | 0.8  | —   | mA   | V <sub>i</sub> = 8 V, V <sub>DS</sub> = 0                       |
|                                             | I <sub>IH(sd)2</sub> | —   | 0.35 | —   | mA   | V <sub>i</sub> = 3.5 V, V <sub>DS</sub> = 0                     |
| Shut down temperature                       | T <sub>sd</sub>      | —   | 175  | —   | °C   | Channel temperature                                             |
| Gate operation voltage                      | V <sub>op</sub>      | 3.5 | —    | 12  | V    |                                                                 |
| Drain current<br>(Current limitation value) | I <sub>D limit</sub> | 20  | —    | —   | A    | V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 10 V <sup>Note 4</sup> |

Note; 4 Pulse test

## Electrical Characteristics

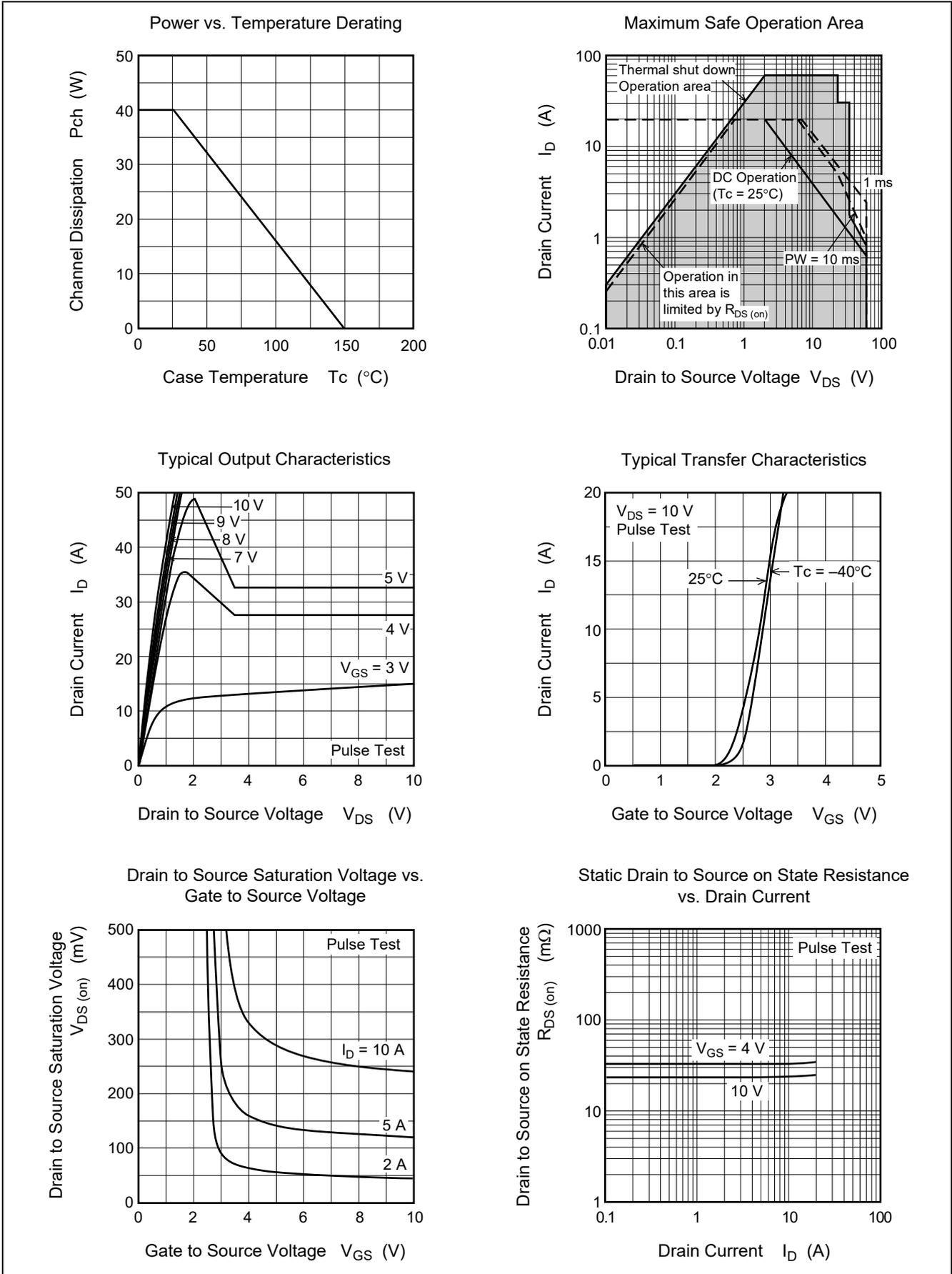
(Ta = 25°C)

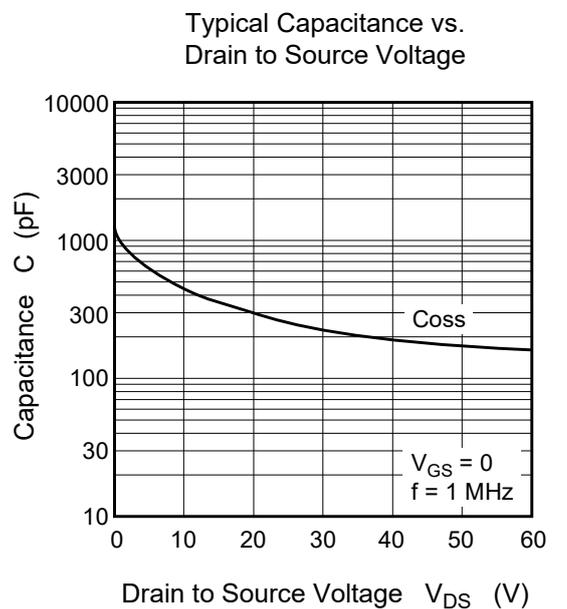
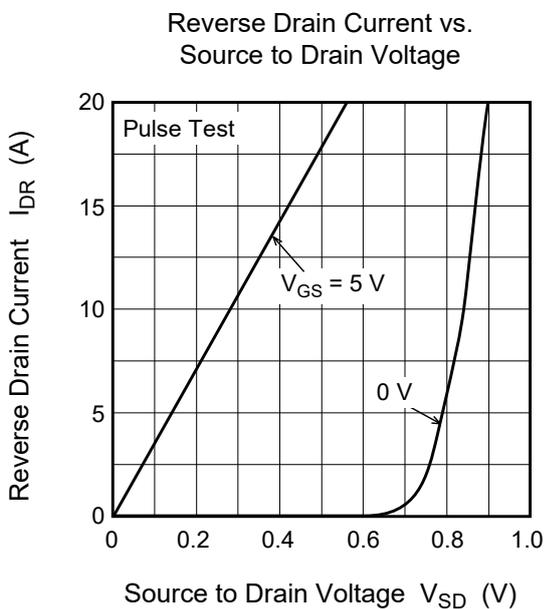
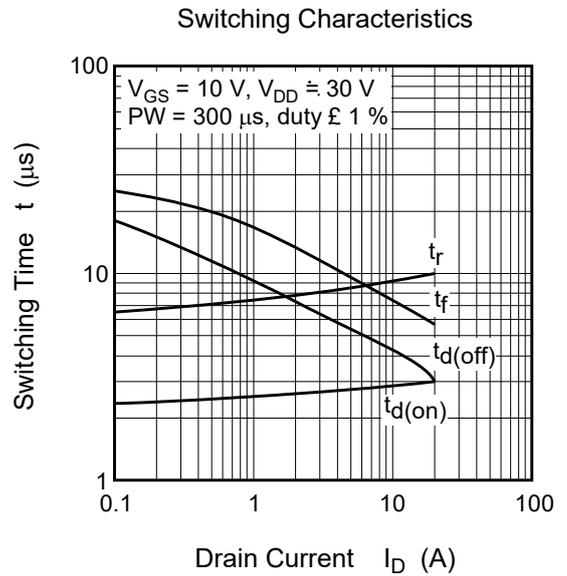
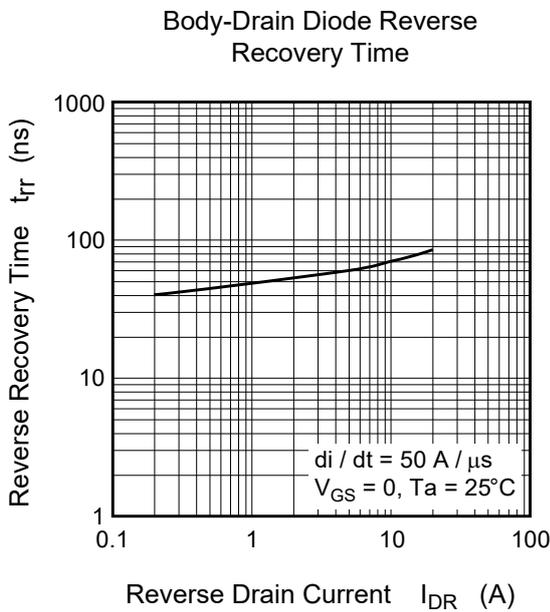
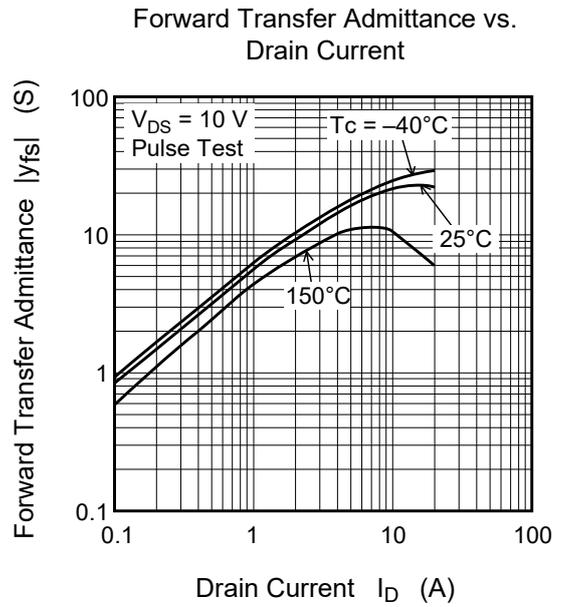
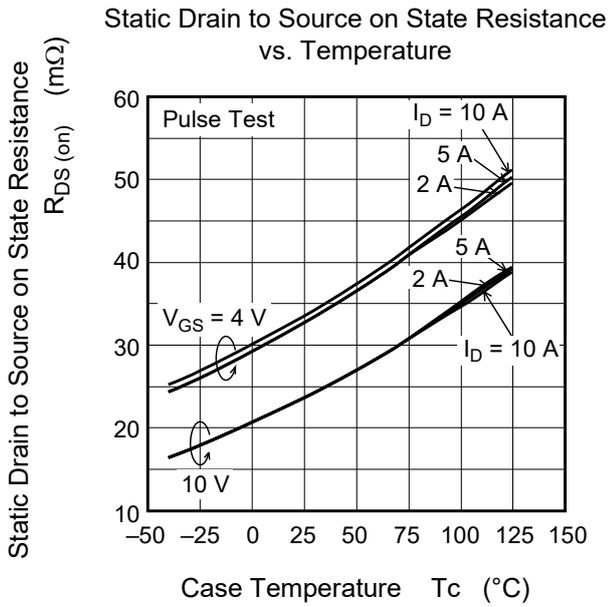
| Item                                                     | Symbol               | Min  | Typ  | Max  | Unit | Test Conditions                                                             |
|----------------------------------------------------------|----------------------|------|------|------|------|-----------------------------------------------------------------------------|
| Drain current                                            | I <sub>D1</sub>      | —    | —    | 35   | A    | V <sub>GS</sub> = 3.5 V, V <sub>DS</sub> = 10 V <sup>Note 5</sup>           |
|                                                          | I <sub>D2</sub>      | —    | —    | 10   | mA   | V <sub>GS</sub> = 1.2 V, V <sub>DS</sub> = 10 V                             |
|                                                          | I <sub>D3</sub>      | 20   | —    | —    | A    | V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 10 V <sup>Note 5</sup>             |
| Drain to source breakdown voltage                        | V <sub>(BR)DSS</sub> | 60   | —    | —    | V    | I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0                                 |
| Gate to source breakdown voltage                         | V <sub>(BR)GSS</sub> | 16   | —    | —    | V    | I <sub>G</sub> = 800 μA, V <sub>DS</sub> = 0                                |
|                                                          | V <sub>(BR)GSS</sub> | -2.5 | —    | —    | V    | I <sub>G</sub> = -100 μA, V <sub>DS</sub> = 0                               |
| Gate to source leak current                              | I <sub>GSS1</sub>    | —    | —    | 100  | μA   | V <sub>GS</sub> = 8 V, V <sub>DS</sub> = 0                                  |
|                                                          | I <sub>GSS2</sub>    | —    | —    | 50   | μA   | V <sub>GS</sub> = 3.5 V, V <sub>DS</sub> = 0                                |
|                                                          | I <sub>GSS3</sub>    | —    | —    | 1    | μA   | V <sub>GS</sub> = 1.2 V, V <sub>DS</sub> = 0                                |
|                                                          | I <sub>GSS4</sub>    | —    | —    | -100 | μA   | V <sub>GS</sub> = -2.4 V, V <sub>DS</sub> = 0                               |
| Input current (shut down)                                | I <sub>GS(OP)1</sub> | —    | 0.8  | —    | mA   | V <sub>GS</sub> = 8 V, V <sub>DS</sub> = 0                                  |
|                                                          | I <sub>GS(OP)2</sub> | —    | 0.35 | —    | mA   | V <sub>GS</sub> = 3.5 V, V <sub>DS</sub> = 0                                |
| Zero gate voltage drain current                          | I <sub>DSS</sub>     | —    | —    | 1    | μA   | V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0,                                |
| Gate to source cutoff voltage                            | V <sub>GS(off)</sub> | 1.1  | —    | 2.1  | V    | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA                               |
| Forward transfer admittance                              | y <sub>fs</sub>      | 12   | 21   | —    | S    | I <sub>D</sub> = 10 A, V <sub>DS</sub> = 10 V <sup>Note 5</sup>             |
| Static drain to source on state resistance               | R <sub>DS(on)</sub>  | —    | 34   | 50   | mΩ   | I <sub>D</sub> = 10 A, V <sub>GS</sub> = 4 V <sup>Note 5</sup>              |
|                                                          | R <sub>DS(on)</sub>  | —    | 24   | 38   | mΩ   | I <sub>D</sub> = 10 A, V <sub>GS</sub> = 10 V <sup>Note 5</sup>             |
| Output capacitance                                       | C <sub>oss</sub>     | —    | 450  | —    | pF   | V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0, f = 1MHz                       |
| Turn-on delay time                                       | t <sub>d(on)</sub>   | —    | 3    | —    | μs   | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A, R <sub>L</sub> = 3 Ω         |
| Rise time                                                | t <sub>r</sub>       | —    | 10   | —    | μs   |                                                                             |
| Turn-off delay time                                      | t <sub>d(off)</sub>  | —    | 4.4  | —    | μs   |                                                                             |
| Fall time                                                | t <sub>f</sub>       | —    | 7.7  | —    | μs   |                                                                             |
| Body-drain diode forward voltage                         | V <sub>DF</sub>      | —    | 0.9  | —    | V    | I <sub>F</sub> = 20 A, V <sub>GS</sub> = 0                                  |
| Body-drain diode reverse recovery time <sup>Note 6</sup> | t <sub>rr</sub>      | —    | 85.3 | —    | ns   | I <sub>F</sub> = 20 A, V <sub>GS</sub> = 0<br>di <sub>F</sub> /dt = 50 A/μs |
| Over load shut down operation time <sup>Note 6</sup>     | t <sub>os1</sub>     | —    | 0.3  | —    | ms   | V <sub>GS</sub> = 5 V, V <sub>DD</sub> = 16 V                               |
|                                                          | t <sub>os2</sub>     | —    | 0.2  | —    | ms   | V <sub>GS</sub> = 5 V, V <sub>DD</sub> = 24 V                               |

Notes: 5. Pulse test

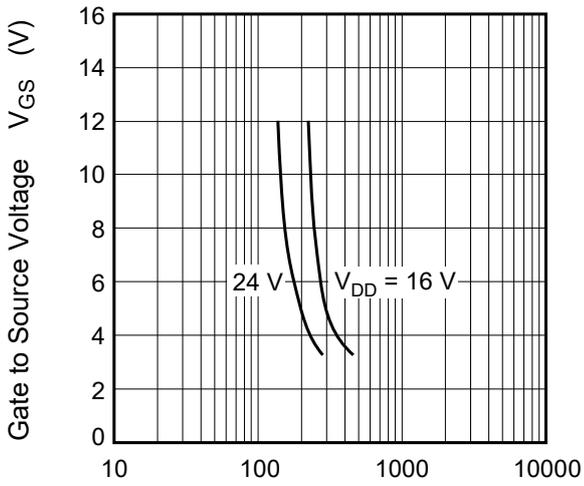
6. Including the junction temperature rise of the over loaded condition.

### Main Characteristics



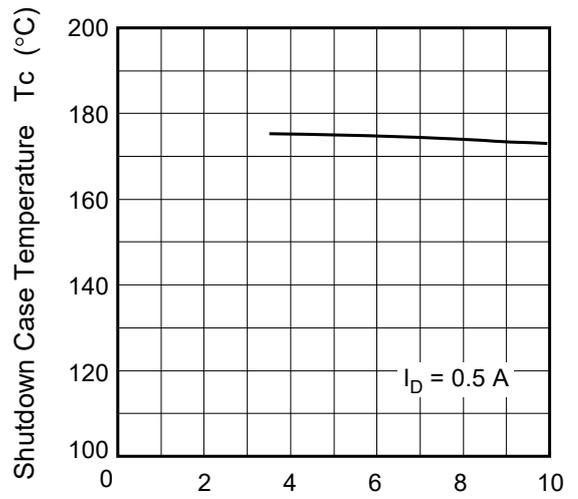


Gate to Source Voltage vs. Shutdown Time of Load-Short Test



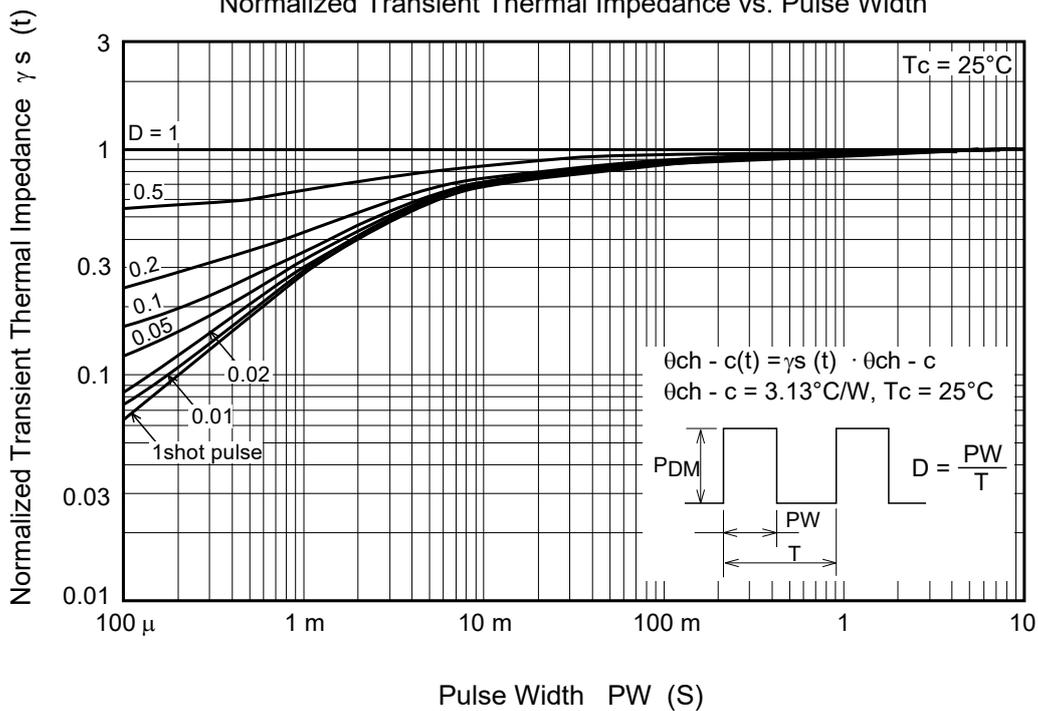
Shutdown Time of Load-Short Test  $P_w$  ( $\mu$ S)

Shutdown Case Temperature vs. Gate to Source Voltage

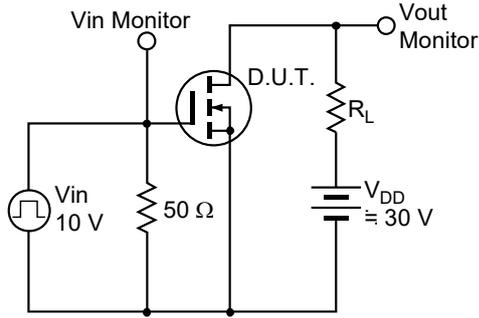


Gate to Source Voltage  $V_{GS}$  (V)

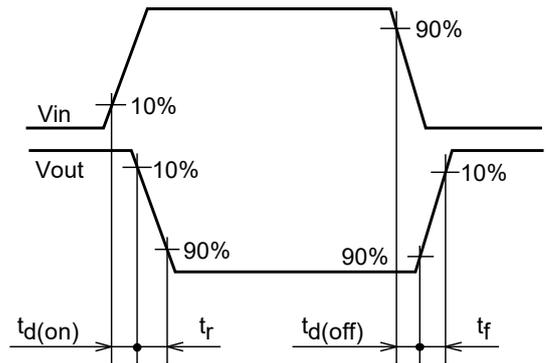
Normalized Transient Thermal Impedance vs. Pulse Width



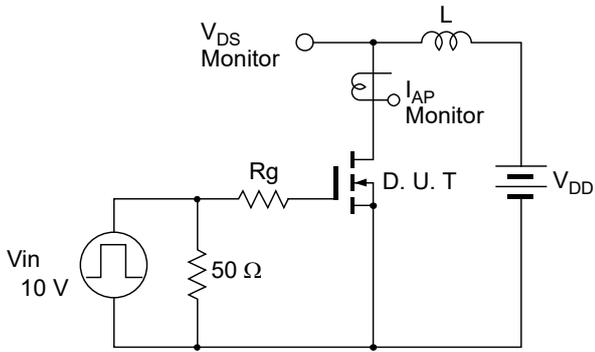
Switching Time Test Circuit



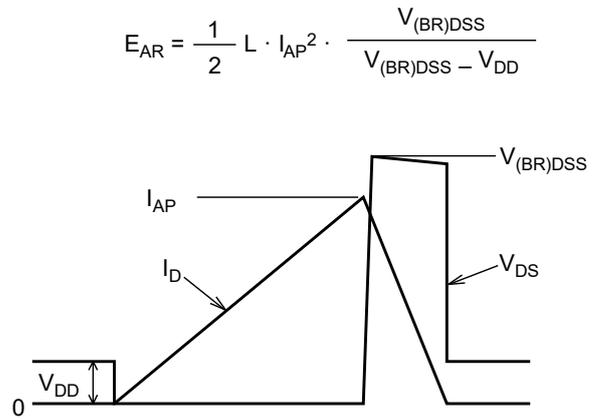
Waveform



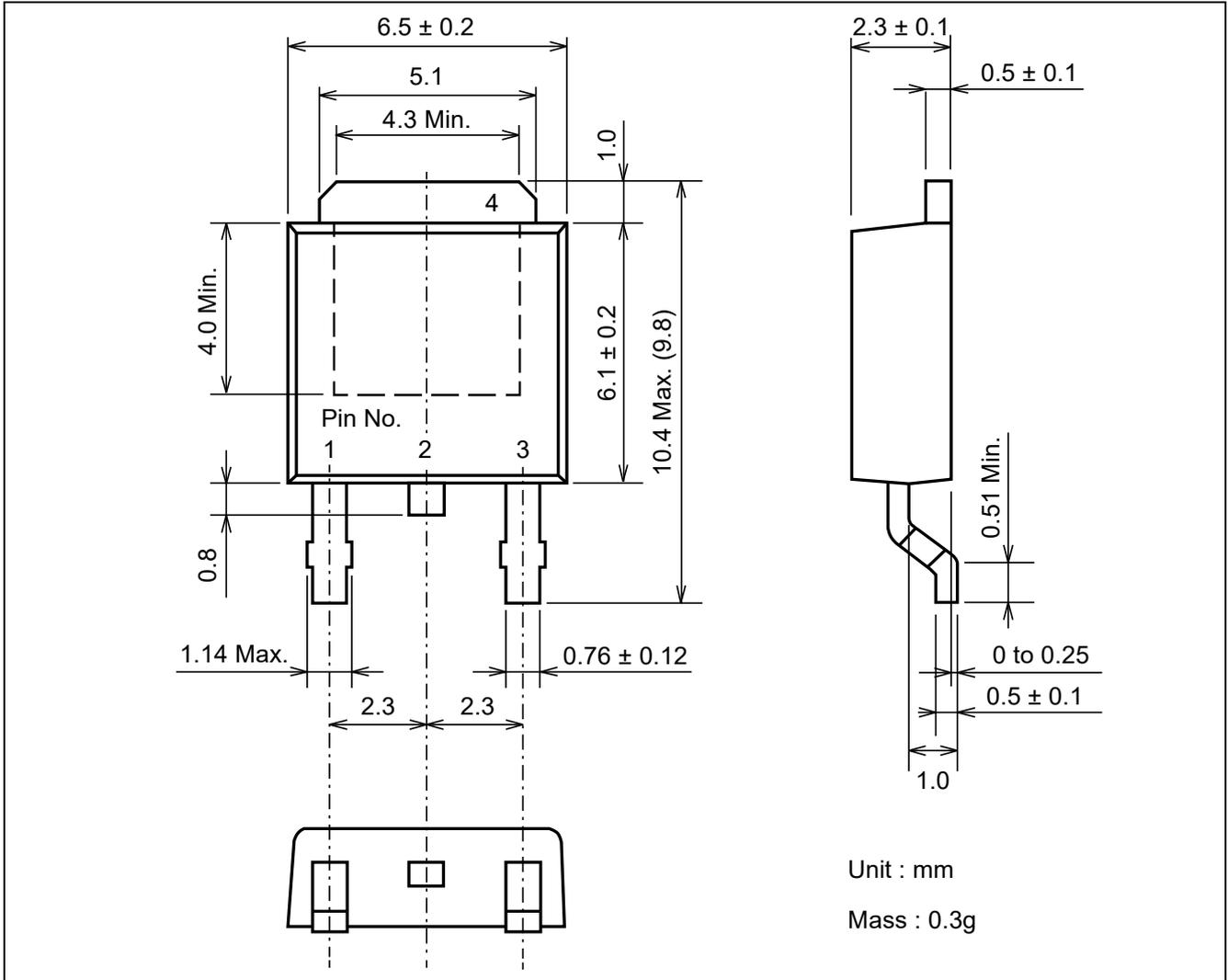
Avalanche Test Circuit



Avalanche Waveform



**Package Dimensions**



**Ordering Information**

| Orderable Part Number | Quantity      | Shipping Container |
|-----------------------|---------------|--------------------|
| RJF0605JPV-00-Q7      | 2500 pcs/reel | Taping             |

Note: The symbol of 2nd "-" is occasionally presented as "#".

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(Rev.5.0-1 October 2020)

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